

FIG. 1

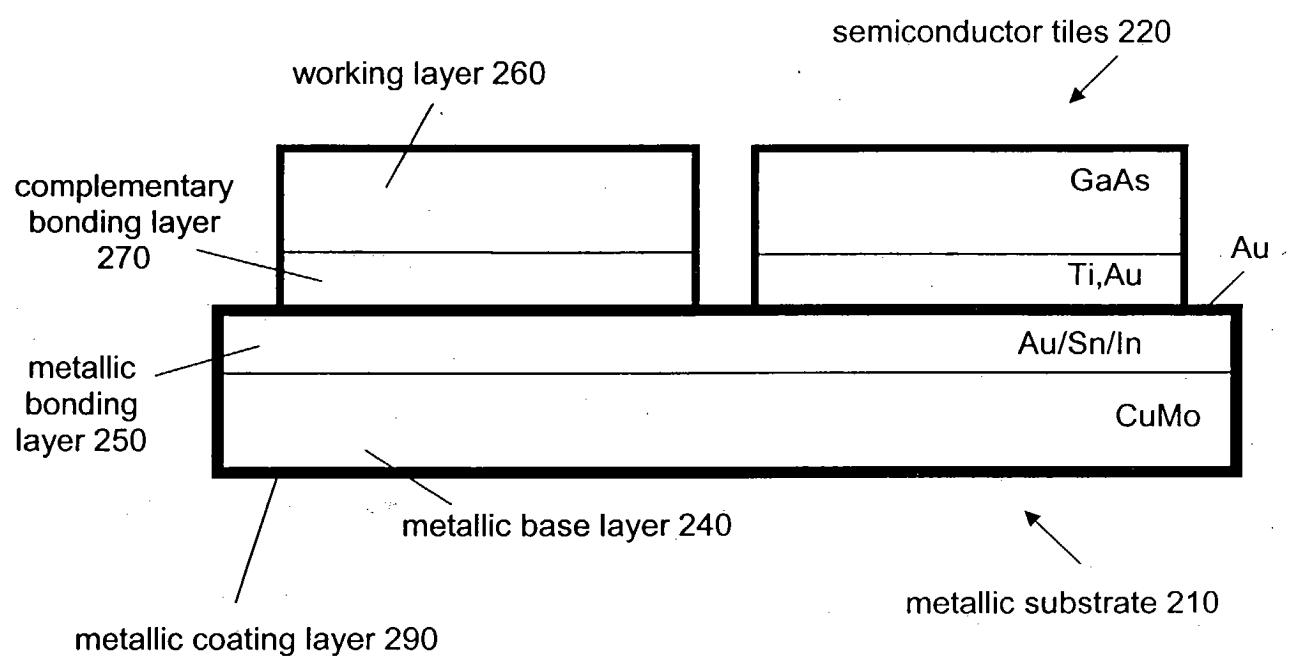


FIG. 2

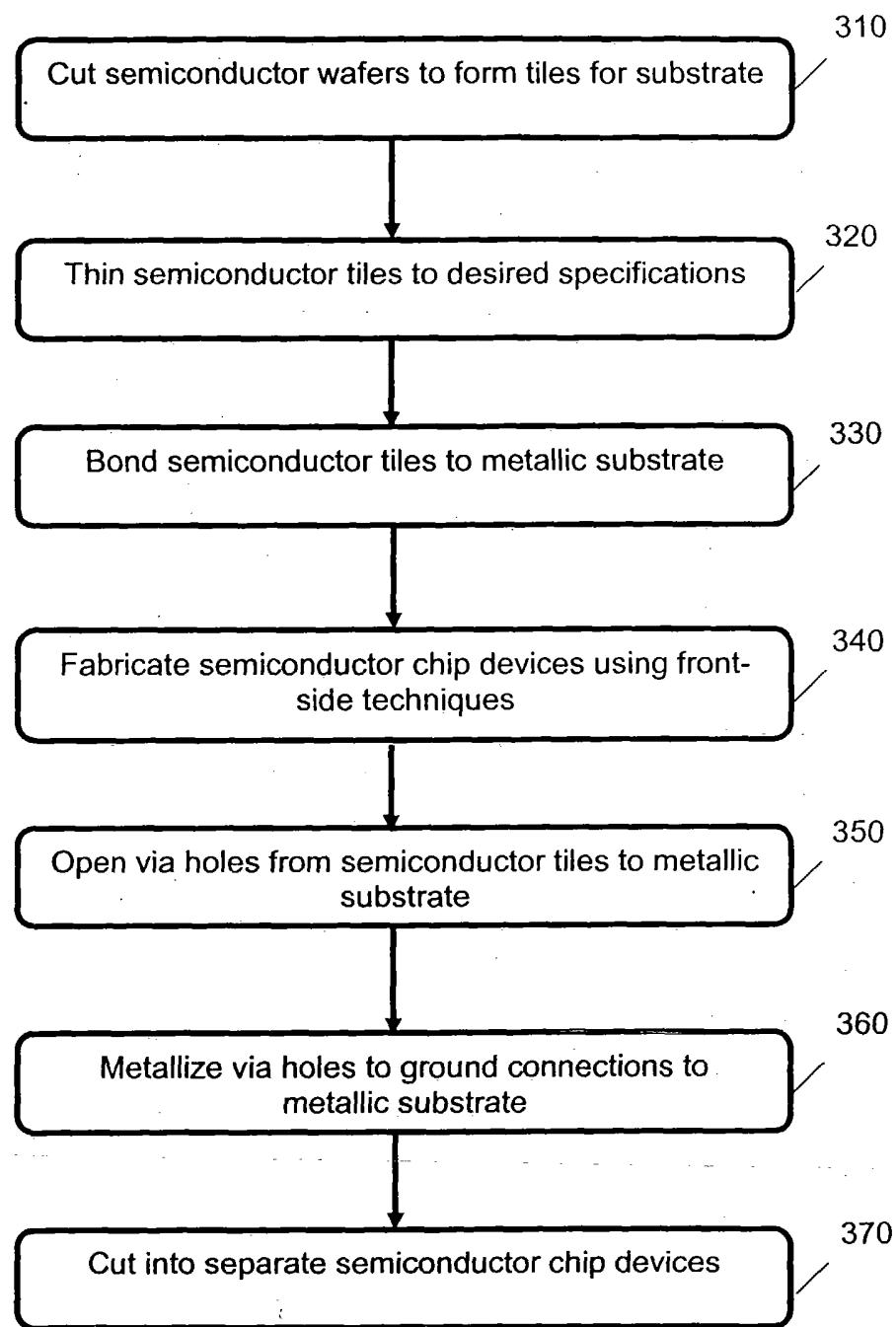


FIG. 3

Basic Description of via trench process:

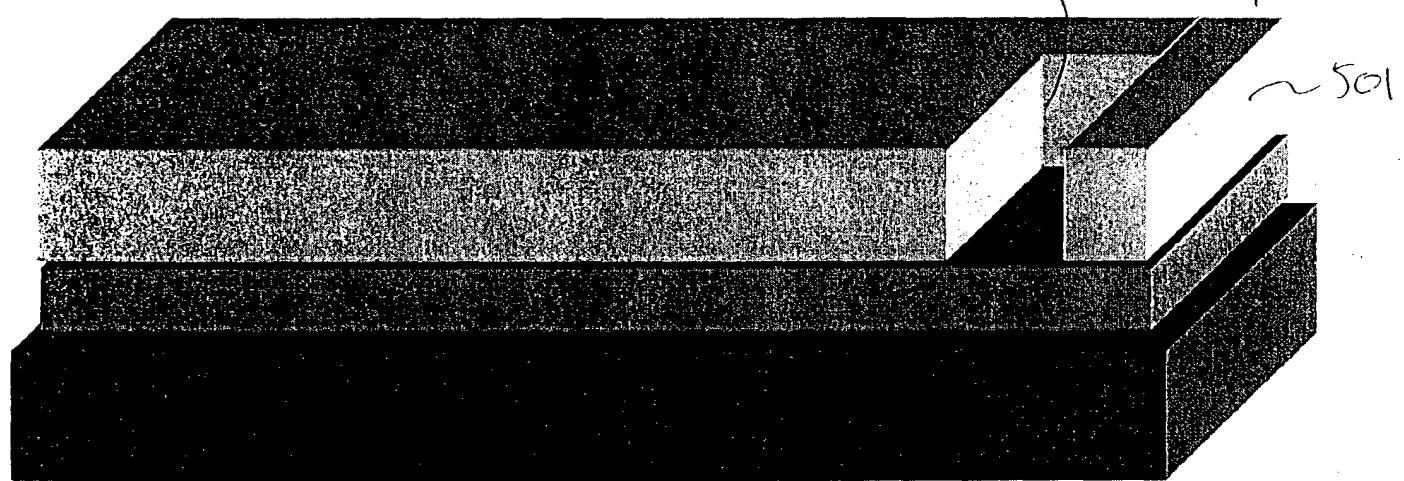
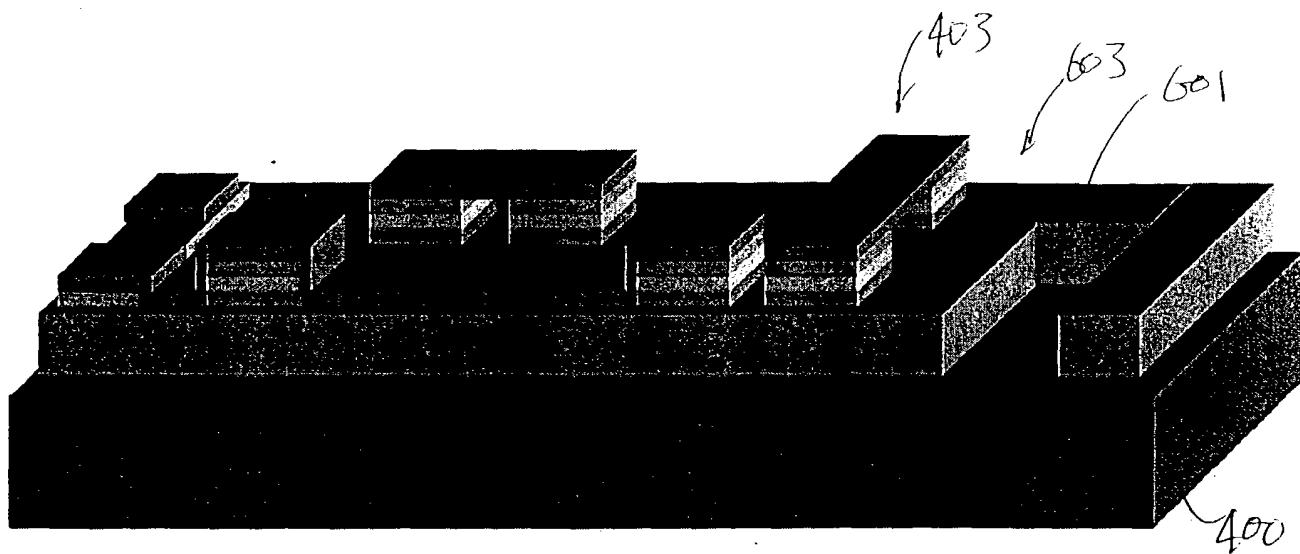
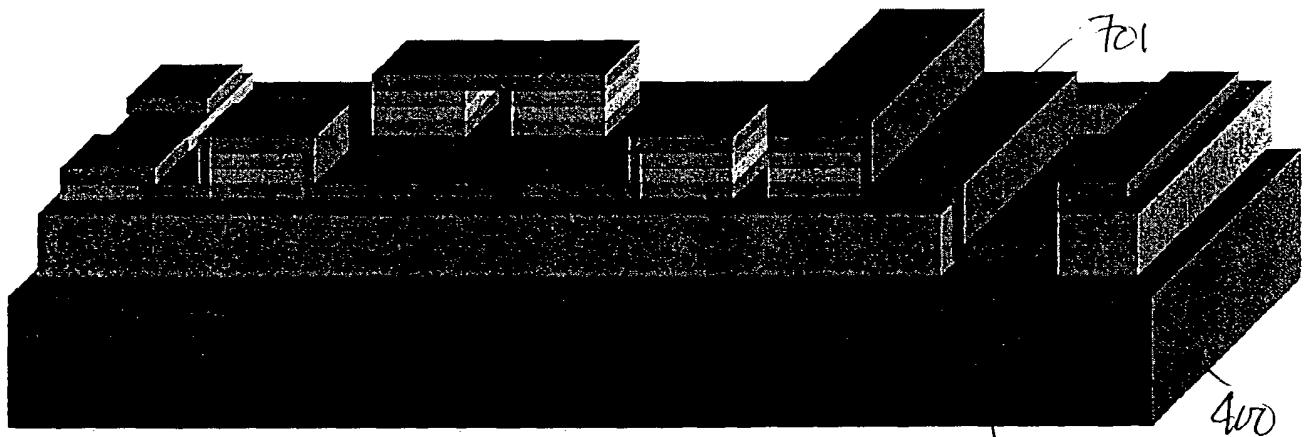


FIG. 5



Via holes/trenches etched using standard etching techniques such as reactive ion etching. PR removed.

FIG. 6



Metal deposited to cover walls of via holes/trenches

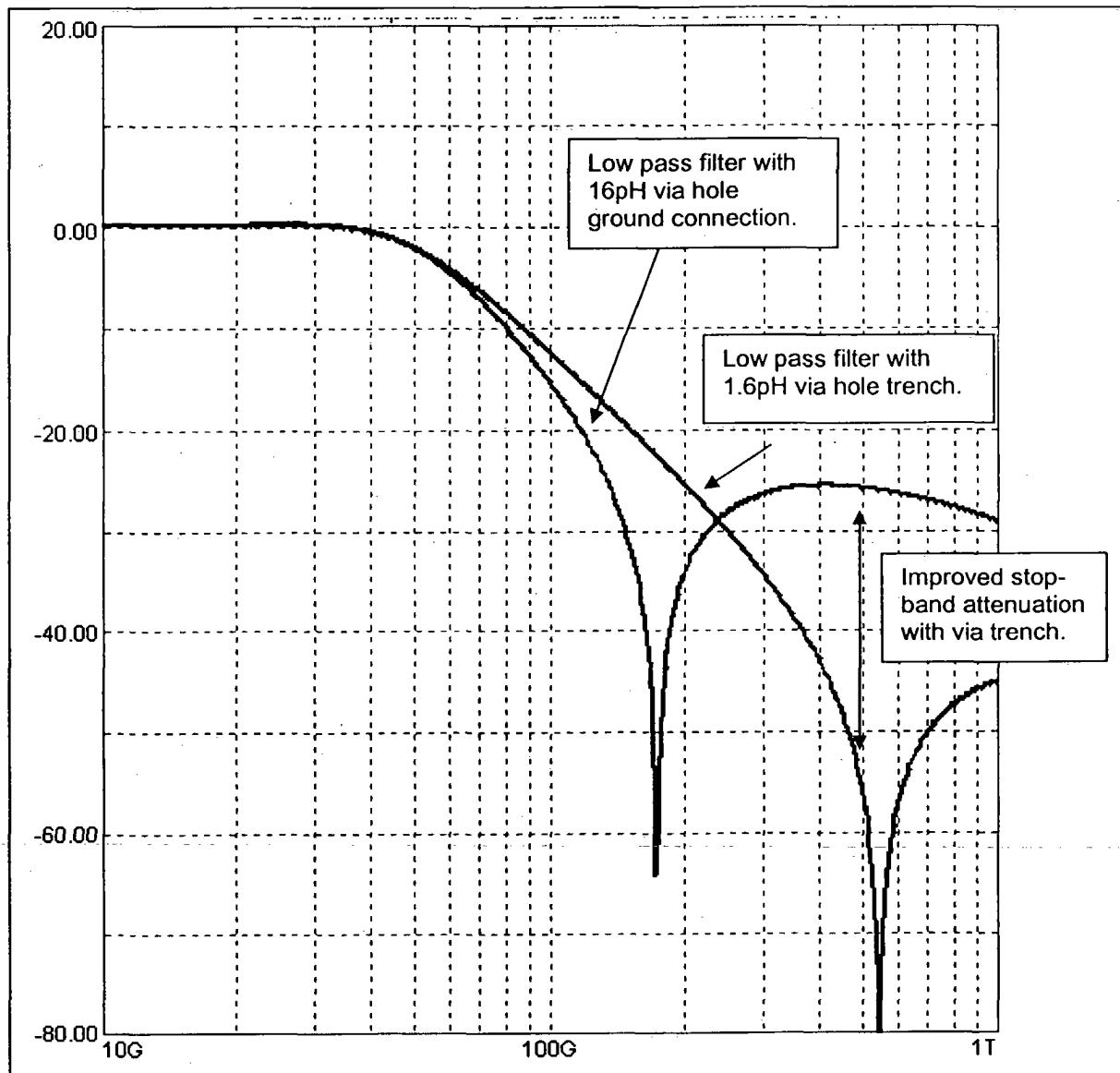
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FIG. 7

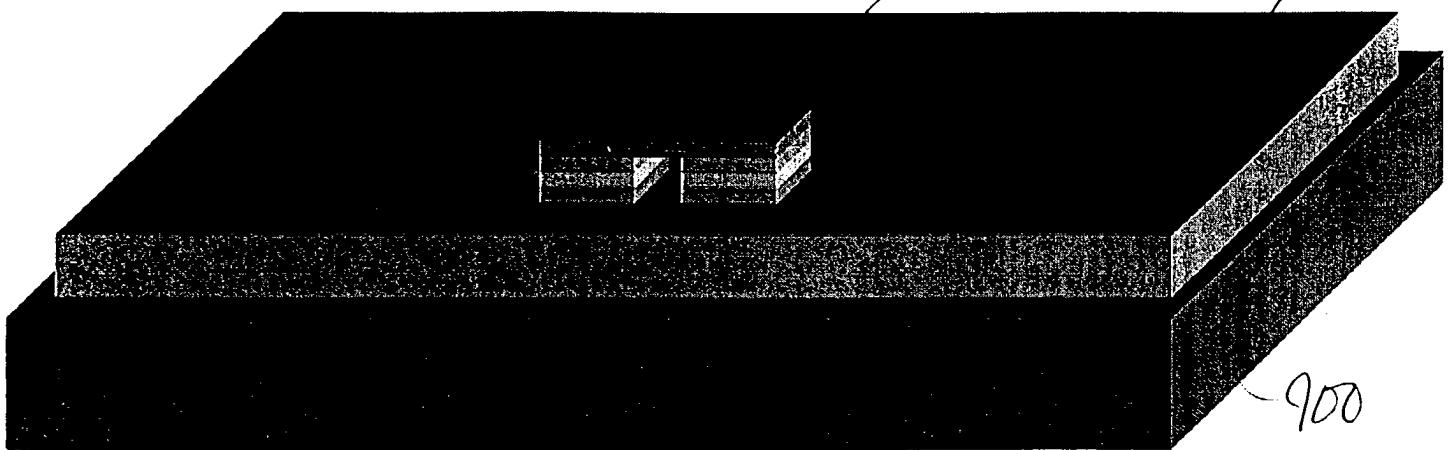
Notes on via hole parameters:

Standard via holes are round with diameters in range 50 – 100 microns. They have between 8 and 16pH of inductance. By increasing the perimeter of the via hole eg so that it forms a trench, a much lower inductance eg 1pH can be obtained . This lower inductance is of benefit in circuits such as amplifiers and filters which require low impedance ground connections at very high frequencies.

FIG. 8

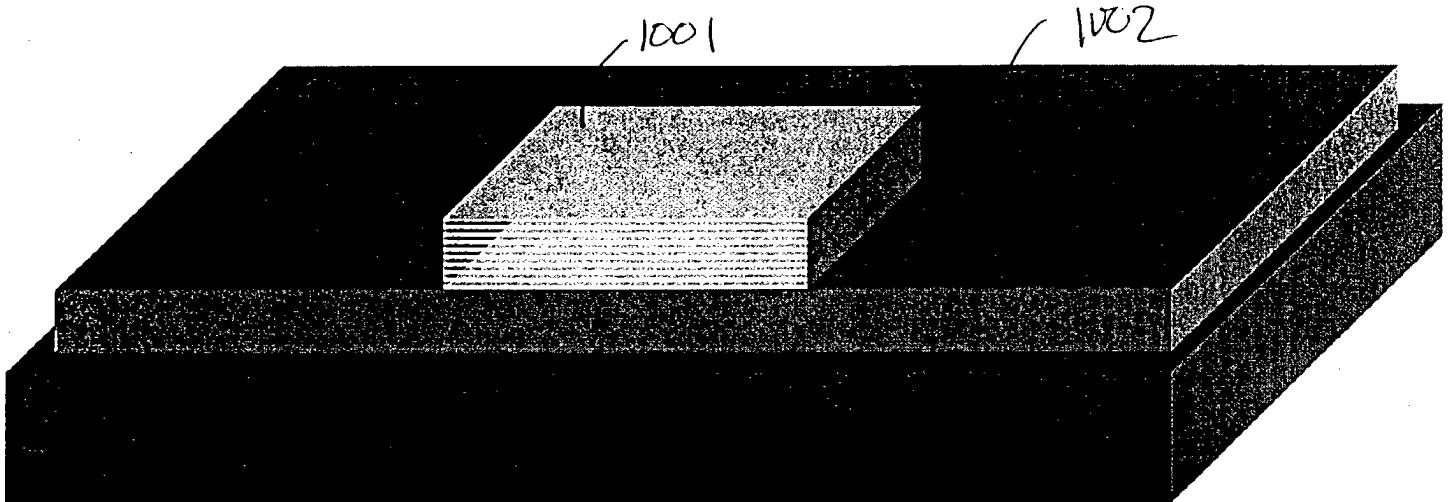


Description of "Metal Box" Feature:



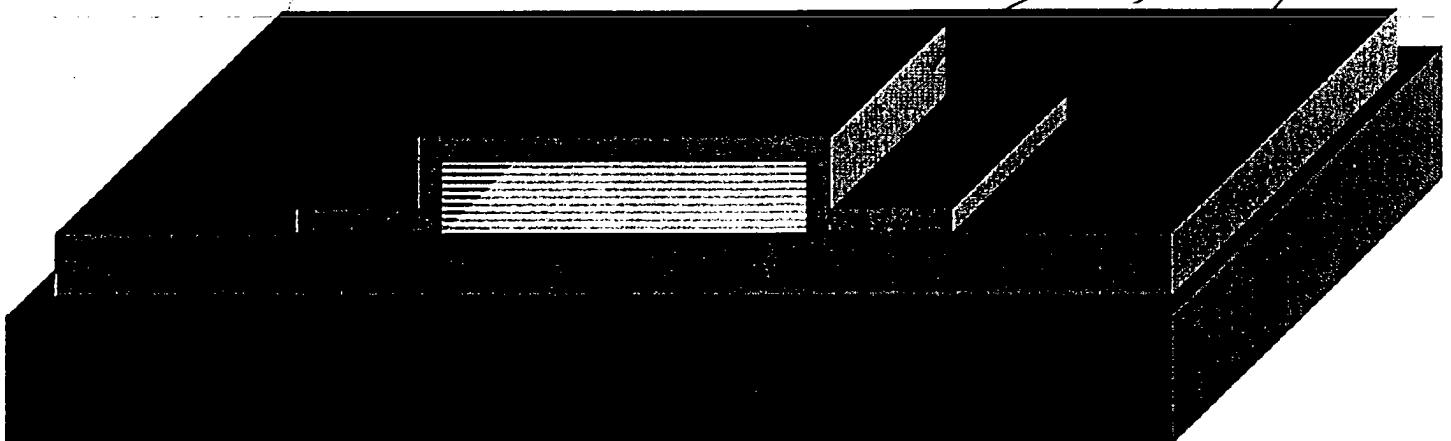
GaAs chip bonded to CuMo substrate with active circuitry on top.

FIG. 9



Wafer covered with polymer such as polyimide. Polymer then patterned by photolithography to cover only certain areas of wafer.

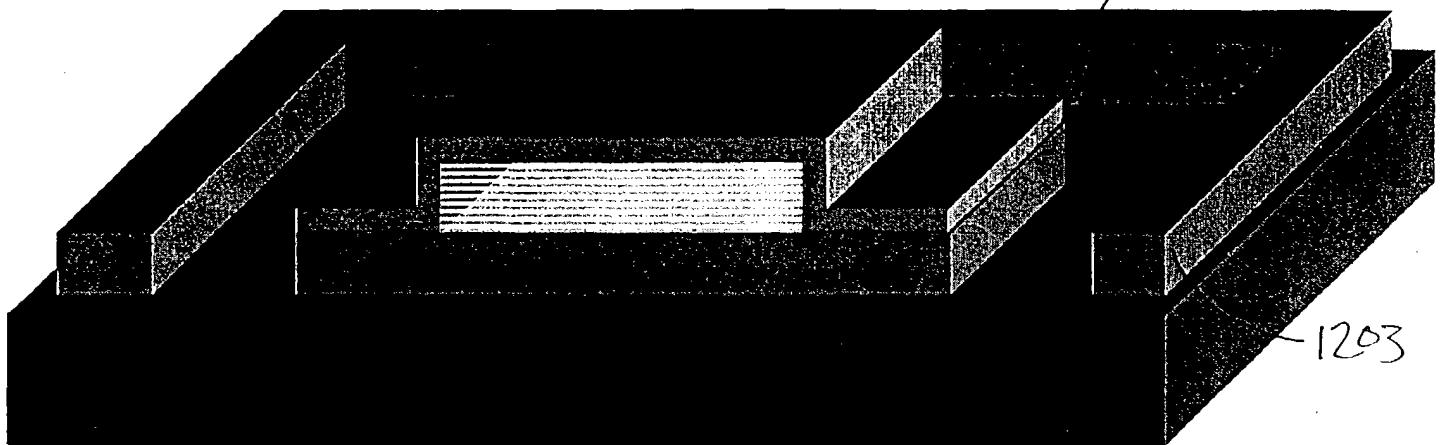
FIG. 10



Wafer cov red with metal. Metal is patterned to only cover polymer.

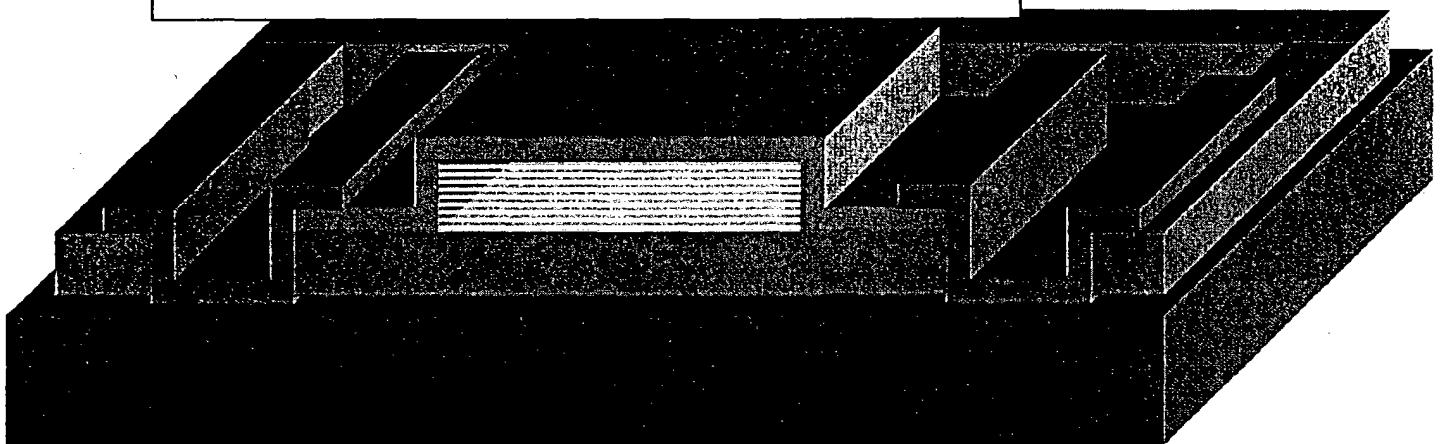
FIG. 11

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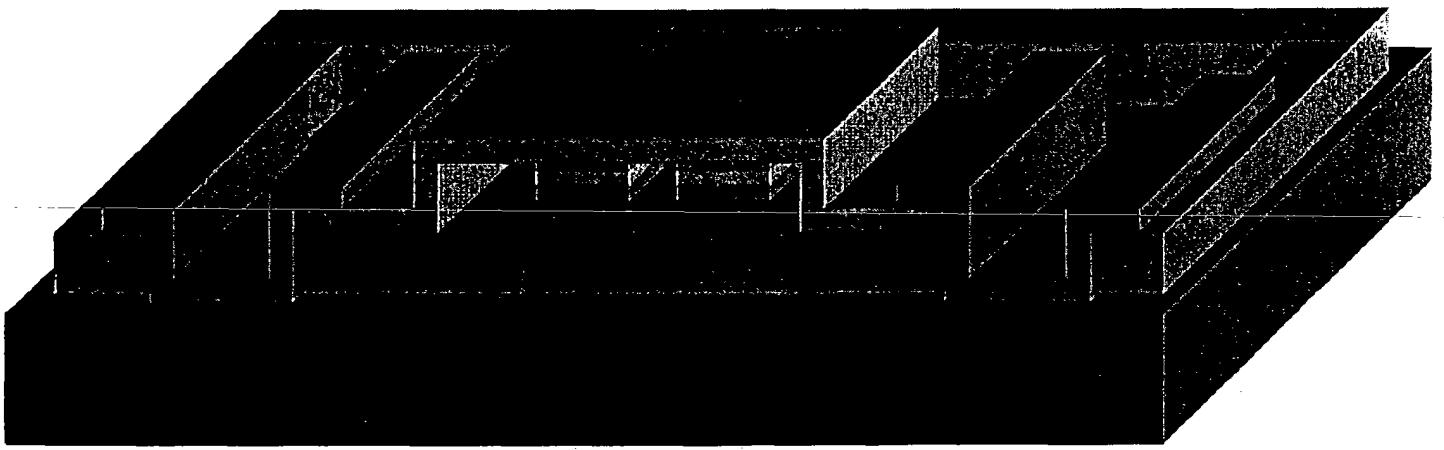
Via hole trench is etched through GaAs surrounding area of active circuitry.

FIG. 12



Metal deposited to cover via trench walls, thereby forming walls of screened box.

FIG. 13



Optionally: polymer is dissolved from under metal "air bridge" to reduce capacitance to active circuitry..

FIG. 14

Notes:

Although the diagrams above show the box "top" being formed first, the walls ie trenches could be formed first with the top added later.

Side view of "box":

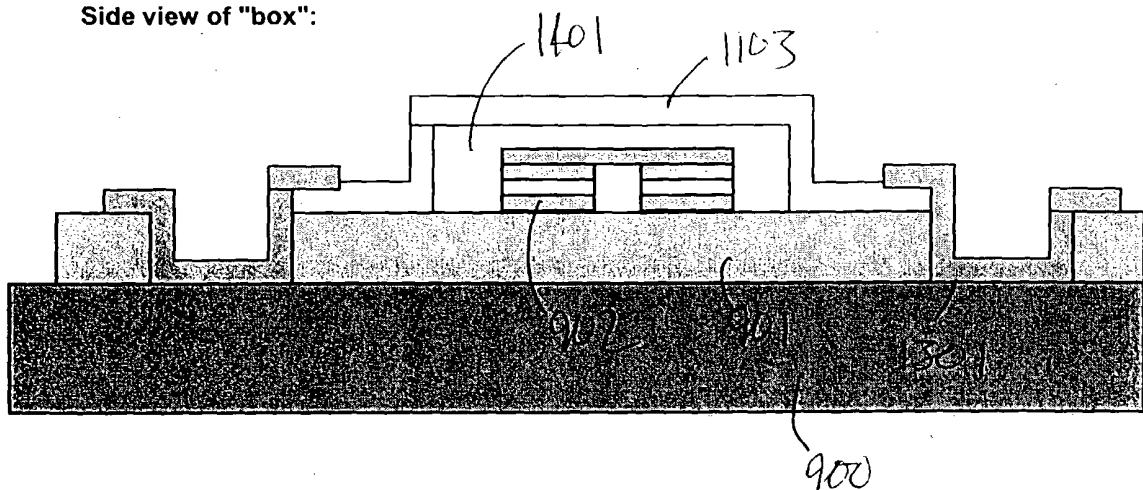


FIG. 15